

Search Notes

Application/Control No.

10/524,493

Examiner

Patricia Leith

Applicant(s)/Patent under
Reexamination

GEACH, MARK

Art Unit

1655

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST:JPO,EPO,DERWENT,USPATF ULL,USPGPUBS,OCBACKFILE	10/21/2007	PL
Inventor name search PALM/EAST	10/21/2007	PL
STN: INDEXED BIOSCIENCE cluster + Napralert databases (approx. 68 databases total)	10/21/2007	PL
EAST:JPO,EPO,DERWENT,USPATF ULL,USPGPUBS,OCBACKFILE continued...	10/22/2007	PL